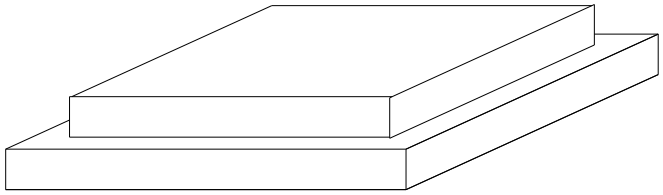

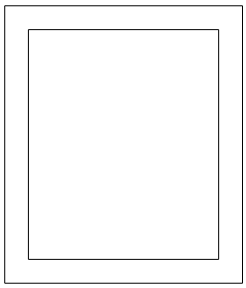

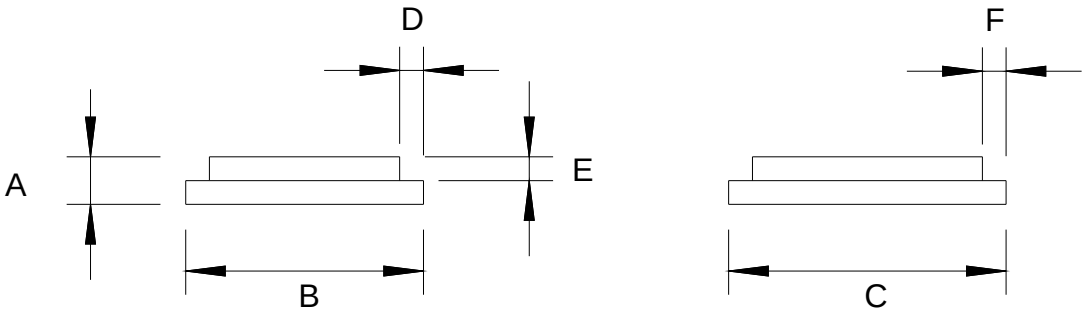

as cut	
one side polished	
both side polished	
roughness	better 30nm
orientation accuracy	< 0,1° deg.
mark for second direction	○ yes ◉ no
reference flat	○ yes ◉ no

A =	mm
B =	mm
C =	mm
D =	mm
E =	mm
F =	mm

Material-Technologie & Kristalle GmbH
Im Langenbroich 20
D-52428 Jülich
Tel.: +49-(0)-24 61-93 52-0
e-mail: info@mateck.de

	Datum	Name
Bearb.	07.09.04	Schröter
Gepr.	.	.
Norm		

Maßstab -

Kristallgeometrie (Viereckig, Hütchenform)

105

Blatt

Blätter

Zust.	Änderung	Datum	Name	Ursprung	Ersatz für:	Ersatz durch: